

Product Change Notification - JAON-19XHUX626

Date:

18 Feb 2019

Product Category:

8-bit Microcontrollers

Affected CPNs:



Notification subject:

CCB 3359 Final Notice: Qualification of ASSH as a new assembly site for selected Atmel products available in 44L VQFN (5x5x1.0mm) package.

Notification text:

PCN Status:

Final notification

PCN Type:

Manufacturing Change

Microchip Parts Affected:

Please open one of the icons found in the Affected CPNs section above.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change:

Qualification of ASSH as a new assembly site for selected Atmel products available in 44L VQFN (5x5x1.0mm) package.

Pre Change:

Assembled at ASKR using palladium coated copper (PdCu) bond wire, EN4900GC (top die) die attach material, QMI536 (bottom die) die attach material and G700LY mold compound material.

Post Change:

Assembled at ASSH using palladium coated copper with gold flash (CuPdAu) bond wire, ATB125 (top and bottom die) die attach material and CEL9240 mold compound material

Pre and Post Change Summary:

	Pre Change	Post Change
Assembly Site	ASE Korea Inc. (ASKR)	ASE-Shanghai (ASSH)
Wire material	PdCu	CuPdAu
Die attach material (Top Die)	EN4900GC	ATB125
Die attach material (Bottom Die)	QMI536	ATB125
Molding compound material	G700LY	CEL9240
Lead frame material	C7025	C7025

Impacts to Data Sheet:

None

Change Impact:

None

Reason for Change:

To improve on-time delivery performance by qualifying ASSH as a new assembly site.

Change Implementation Status:

In Progress



Estimated First Ship Date:

March 18, 2019 (date code: 1912)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

Time Table Summary:

	April 2018				Ш 5%	February 2019				March 2019						
Workweek	14	15	16	17	18	□ 90 *	05	06	07	08	09	10	11	12	13	14
Initial PCN Issue				>												
Date				^												
Qual Report										Χ						
Availability										^						
Final PCN Issue Date										X						
Estimated														Χ		
Implementation Date														^		

Method to Identify Change:

Traceability code

Qualification Report:

Please open the attachments included with this PCN labeled as PCN_#_Qual_Report.

Revision History:

April 23, 2018: Issued initial notification.

February 18, 2019: Issued final notification. Attached is the qualification report. Provided estimated first ship date on March 18, 2019.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachment(s):

PCN JAON-19XHUX626 Qual Report.pdf

Please contact your local <u>Microchip sales office</u> with questions or concerns regarding this notification.

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If you wish to <u>change your PCN profile, including opt out,</u> please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

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Affected Catalog Part Numbers (CPN)

ATMEGA164A-MCH

ATMEGA164A-MCHR

ATMEGA164PA-MCH

ATMEGA164PA-MCHR

ATMEGA324A-MCH

ATMEGA324A-MCHR

ATMEGA324PA-MCH

ATMEGA324PA-MCHR

Date: Sunday, February 17, 2019



QUALIFICATION REPORT SUMMARY

RELIABILITY LABORATORY

PCN #: JAON-19XHUX626

Date: February 01, 2019

Qualification of ASSH as a new assembly site for selected Atmel products available in 44L VQFN (5x5x1.0mm) package



Purpose Qualification of ASSH as a new assembly site for selected Atmel products available in

44L VQFN (5x5x1.0mm) package

CN ES231672

QUAL ID Q18148 Rev. A **MP CODE** 354557S3BC03

Part No. ATMEGA324PA-MCH
Bonding No. BDM-001793 Rev. A

CCB No. 3359

Package

Type 44L VQFN Package size 5x5x1.0 mm

Die thickness 6 mils

Die size 124.0 x 131.0 mils

Lead Frame

Paddle size 118 x 118 mils

Material C7025 Surface PPF

Process Etched frame

Lead Lock No

Part Number LI-WDQ000044-01

Treatment Roughened

Material

Epoxy ATB125

Wire CuPdAu wire

Mold Compound CEL-9240

Plating Composition NiPdAu



Manufacturing Information

Assembly Lot No.	Wafer No.	Date Code
ASSH191000026.000	MCSO518415051.100	1823908
ASSH191000027.000	MCSO518415051.100	182390R
ASSH191000028.000	MCSO518415051.100	182391C

Result	X Pass	Fail	
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44L VQFN (5x5x1.0 mm) assembled by ASSH pass reliability test per QCI-39000. This package was qualified the Moisture/Reflow Sensitivity Classification Level 3 at 260°C reflow temperature per IPC/JEDEC J-STD-020D standard.

	PACKAGE QUALII	FICATION	ON R	EPOR	RT	
Test Number (Reference)	Test Condition	Standard / Method	Qty. (Acc.)	Def/SS	Result	Remarks
Moisture/Reflow Sensitivity Classification Test (At MSL Level 3)	30°C/ 60%RH Moisture Soak 192 hrs. System: TABAI ESPEC Model PR-3SPH 3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243	IPC/JEDE C J-STD- 020D	198	0/198	Pass	
	(IPC/JEDEC J-STD-020D)					
Precondition Prior Perform Reliability Tests	Electrical Test :+25°C and 85°C System: magnum	JESD22- A113	693(0)	693		Good Devices
(At MSL Level 3)	Bake 150°C, 24 hrs System: CHINEE			693		
	30°C/60%RH Moisture Soak 192 hrs. System: TABAI ESPEC Model PR-3SPH			693		
	3x Convection-Reflow 265°C max			693		
	System: Vitronics Soltec MR1243					
	Electrical Test :+25°C and 85°C System: magnum			0/693	Pass	
Temp Cycle	Stress Condition: -65°C to +150°C, 500 Cycles System: TABAI ESPEC TSA-70H	JESD22- A104		231		Parts had been pre-conditioned at 260°C
	Electrical Test: + 85°C System: magnum		231(0)	0/231	Pass	
UNBIASED-	Stress Condition: +130°C/85%RH, 96 hrs. System: HAST 6000X	JESD22- A118		231		Parts had been pre-conditioned at 260°C
HAST	Electrical Test: + 25°C System: magnum		231(0)	0/231	Pass	
High	Stress Condition: Bake 175°C, 504 hrs System: SHEL LAB	JESD22- A103		135		45 units / lot
Temperature Storage Life	Electrical Test :+25°C and 85°C System: magnum		135(0)	0/135	Pass	
Bond Strength	Wire Pull (> 2.5 grams)	M2011 JESD22- B116	30 (0) Wires	0/30	Pass	
Data Assembly	Bond Shear (>15.00 grams)		30 (0) bonds	0/30	Pass	